

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Moshe Sarfaty et al. Art Unit : Unknown
Serial No. : Unassigned Examiner : Unknown
Filed : July 10, 2003
Title : EDDY-OPTIC SENSOR FOR OBJECT INSPECTION

Mail Stop Patent Application
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

Under 35 USC §120, this application relies on the earlier filing date of application serial number 09/812,329, filed on March 19, 2001. The following references were submitted to and/or cited by the Office in the prior application and, therefore, are not provided in this application:


Desig. IDs:

AA-AH

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 7/10/03



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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 05542-548002	Application No. Unassigned
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Moshe Sarfaty et al.	
		Filing Date July 10, 2003	Group Art Unit Unknown

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	4,849,694	07/18/89	Coates			
	AB	4,963,500	10/16/90	Cogan et al.			
	AC	5,451,863	09/19/95	Freeman			
	AD	5,525,903	06/11/96	Mandl et al.			
	AE	5,640,242	06/17/97	O'Boyle et al.			
	AF	5,719,495	02/17/98	Moslehi			
	AG	5,929,994	07/27/99	Lee et al.			
	AH	6,034,781	03/07/00	Sarfaty et al.			
	AI						
	AJ						
	AK						
	AL						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AM							
	AN							
	AO							
	AP							
	AQ							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AR	
	AS	
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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	